

- 2.Choice of charging period, T
- Minimise individual signals & maximise the spacing between the primary spectral peaks by discharging as frequently as is feasible.
- If can measure offsets and charging rate, may be possible to optimise T, so resultant signal minimised- depends on offsets, so cannot be ensured?

3.Choice of system parameters • Large electrode-test mass gaps

•Choose $\sum_{i,N}^{N-1} C_{i,N} V_i \approx 0$

- Large mass
- Minimise voltages & voltage differences
- 4.Minimise offsets
- Level to which geometrical offsets can be reduced is limited by
 e.g. machining accuracy & test mass positioning accuracy.
- Voltage offsets in the system are unavoidable due to patch effects and work-function variations. The level to which these can be balanced will then determine the residual voltage offsets in the system (W. Weber et al SPIE, 2002)



5.Spectral analysis

- Expect, ultimately, signals will be removed via analysis
- Use e.g. pattern matching to extract signal
- Cross-correlate O/P from different test masses ? (limited by differences in mean charging rate)
- Cross-correlate O/P from different DoFs ? (limited by sensitivity)

LIG<mark>O-G030486-00-Z</mark>